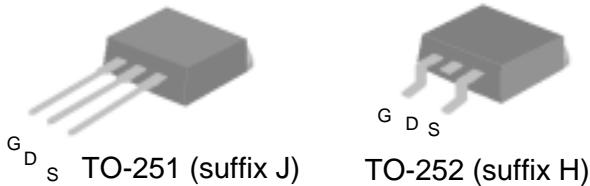


N-channel Enhancement-mode Power MOSFET

PRODUCT SUMMARY

BV _{DSS}	30V
R _{DS(ON)}	9mΩ
I _D	60A

 Pb-free; RoHS-compliant TO-251 (IPAK) and TO-252 (DPAK)



ABSOLUTE MAXIMUM RATINGS

Symbol	Parameter	Value	Units
V _{DS}	Drain-source voltage	30	V
V _{GS}	Gate-source voltage	±20	V
I _D	Continuous drain current, T _C = 25°C	60	A
	T _C = 100°C	43	A
I _{DM}	Pulsed drain current ¹	195	A
P _D	Total power dissipation, T _C = 25°C	53	W
	Linear derating factor	0.36	W/°C
E _{AS}	Single pulse avalanche energy ³	29	mJ
T _{STG}	Storage temperature range	-55 to 175	°C
T _J	Operating junction temperature range	-55 to 175	°C

THERMAL CHARACTERISTICS

Symbol	Parameter	Value	Units
R _{ΘJC}	Maximum thermal resistance, junction-case	2.8	°C/W
R _{ΘJA}	Maximum thermal resistance, junction-ambient	110	°C/W

Notes:

1. Pulse width must be limited to avoid exceeding the safe operating area.

2. Pulse width <300us, duty cycle <2%.

3. V_{DD}=25V , L=100uH , R_G=25Ω , I_{AS}=24A.

ELECTRICAL CHARACTERISTICS (at $T_j = 25^\circ\text{C}$, unless otherwise specified)

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Units
BV_{DSS}	Drain-source breakdown voltage	$V_{\text{GS}}=0\text{V}$, $I_{\text{D}}=250\mu\text{A}$	30	-	-	V
$\Delta \text{BV}_{\text{DSS}}/\Delta T_j$	Breakdown voltage temperature coefficient	Reference to 25°C , $I_{\text{D}}=1\text{mA}$	-	0.032	-	$\text{V}/^\circ\text{C}$
$R_{\text{DS(ON)}}$	Static drain-source on-resistance	$V_{\text{GS}}=10\text{V}$, $I_{\text{D}}=33\text{A}$	-	-	9	$\text{m}\Omega$
		$V_{\text{GS}}=4.5\text{V}$, $I_{\text{D}}=20\text{A}$	-	-	18	$\text{m}\Omega$
$V_{\text{GS(th)}}$	Gate threshold voltage	$V_{\text{DS}}=V_{\text{GS}}$, $I_{\text{D}}=250\mu\text{A}$	1	-	3	V
g_{fs}	Forward transconductance	$V_{\text{DS}}=10\text{V}$, $I_{\text{D}}=33\text{A}$	-	35	-	S
I_{DSS}	Drain-source leakage current	$V_{\text{DS}}=30\text{V}$, $V_{\text{GS}}=0\text{V}$	-	-	1	uA
		$V_{\text{DS}}=24\text{V}$, $V_{\text{GS}}=0\text{V}$, $T_j=175^\circ\text{C}$	-	-	250	uA
I_{GSS}	Gate-source leakage current	$V_{\text{GS}}= \pm 20\text{V}$	-	-	± 100	nA
Q_g	Total gate charge ²	$I_{\text{D}}=33\text{A}$	-	16.5	-	nC
Q_{gs}	Gate-source charge		-	5	-	nC
Q_{gd}	Gate-drain ("Miller") charge		-	10.3	-	nC
$t_{\text{d(on)}}$	Turn-on delay time ²	$V_{\text{DS}}=15\text{V}$ $I_{\text{D}}=33\text{A}$	-	8.2	-	ns
t_r	Rise time		-	105	-	ns
$t_{\text{d(off)}}$	Turn-off delay time		-	21.4	-	ns
t_f	Fall time		-	8.5	-	ns
C_{iss}	Input capacitance	$V_{\text{GS}}=0\text{V}$ $V_{\text{DS}}=25\text{V}$	-	1485	-	pF
C_{oss}	Output capacitance		-	245	-	pF
C_{rss}	Reverse transfer capacitance		-	170	-	pF

Source-Drain Diode

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Units
V_{SD}	Forward voltage ²	$I_{\text{S}}=60\text{A}$, $V_{\text{GS}}=0\text{V}$	-	-	1.3	V
t_{rr}	Reverse-recovery time ²	$I_{\text{S}}=30\text{A}$, $V_{\text{GS}}=0\text{V}$,	-	29	-	ns
Q_{rr}	Reverse-recovery charge	$dI/dt=100\text{A}/\mu\text{s}$	-	12	-	nC

Notes:

1. Pulse width must be limited to avoid exceeding the safe operating area.

2. Pulse width <300us, duty cycle <2%.

3. $V_{\text{DD}}=25\text{V}$, $L=100\mu\text{H}$, $R_{\text{G}}=25\Omega$, $I_{\text{AS}}=24\text{A}$.

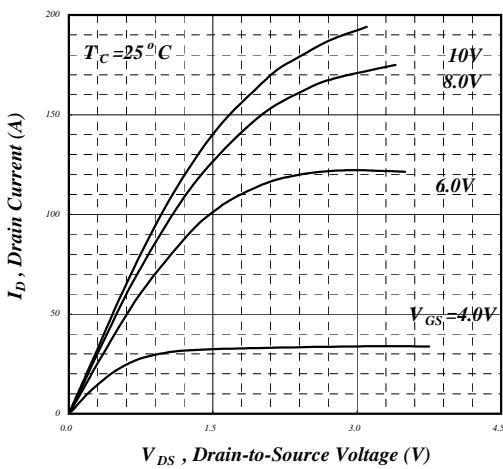


Fig 1. Typical Output Characteristics

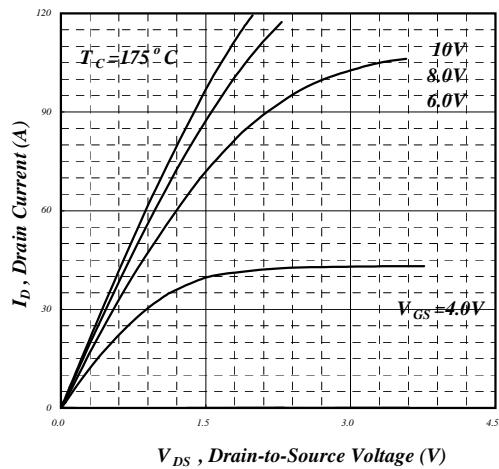


Fig 2. Typical Output Characteristics

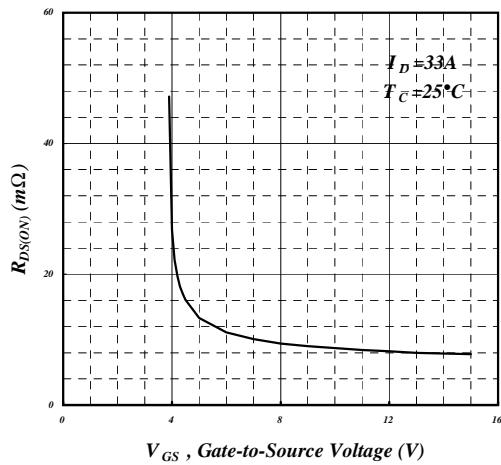


Fig 3. On-Resistance vs. Gate Voltage

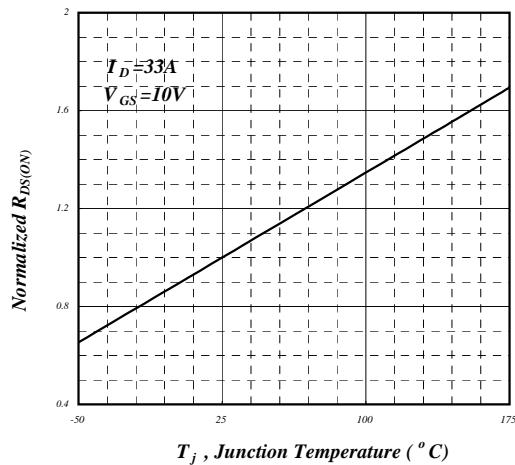


Fig 4. Normalized On-Resistance vs. Junction Temperature

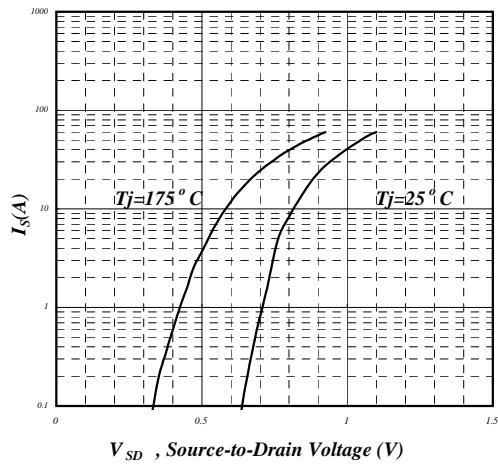


Fig 5. Forward Characteristic of Reverse Diode

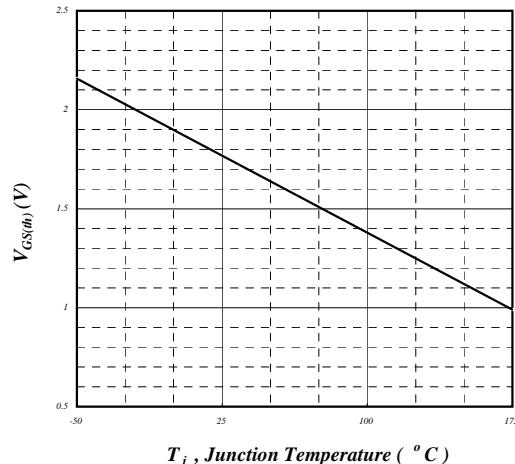


Fig 6. Gate Threshold Voltage vs. Junction Temperature

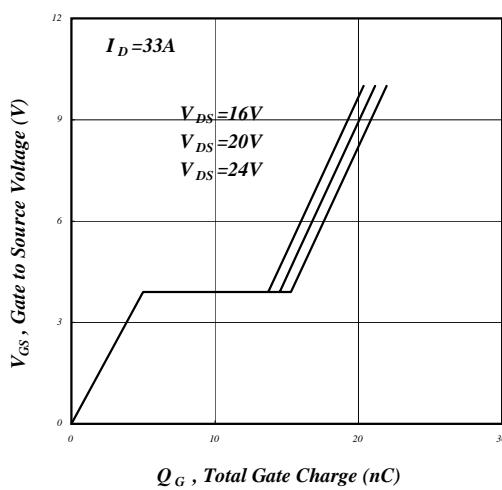


Fig 7. Gate Charge Characteristics

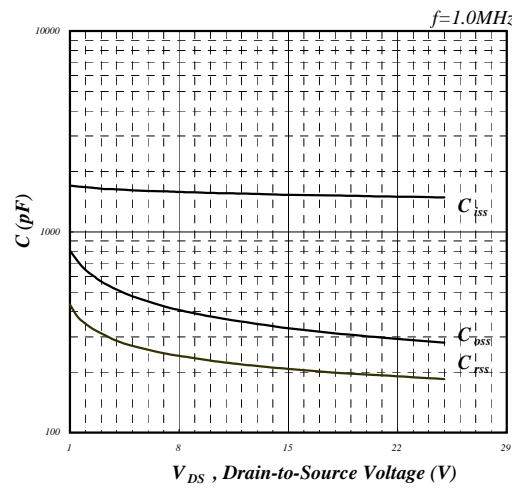


Fig 8. Typical Capacitance Characteristics

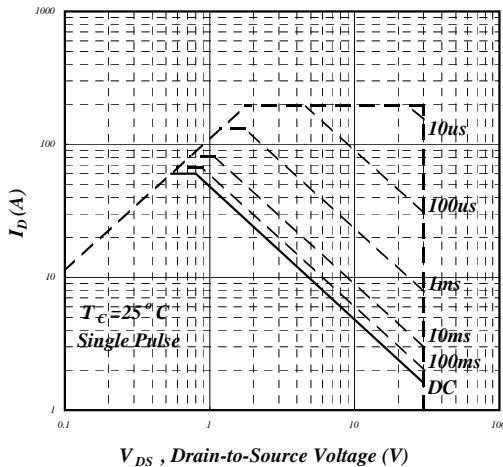


Fig 9. Maximum Safe Operating Area

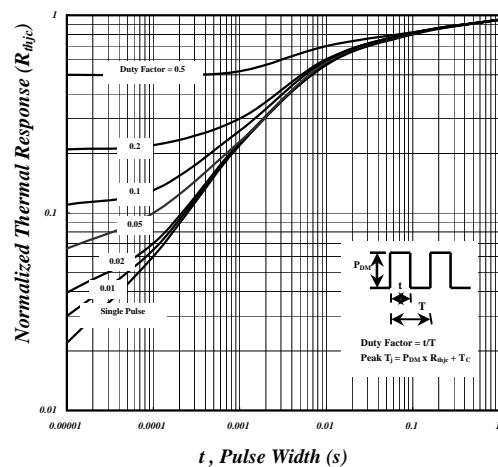


Fig 10. Effective Transient Thermal Impedance

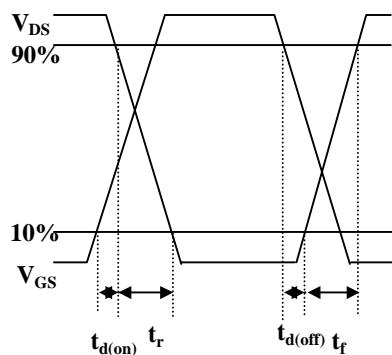


Fig 11. Switching Time Waveform

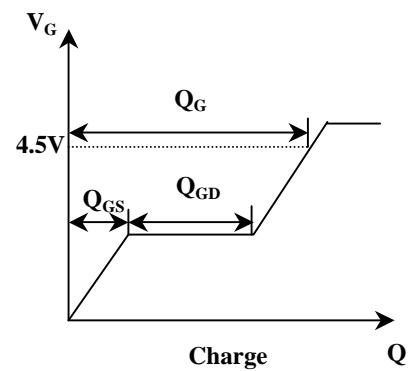
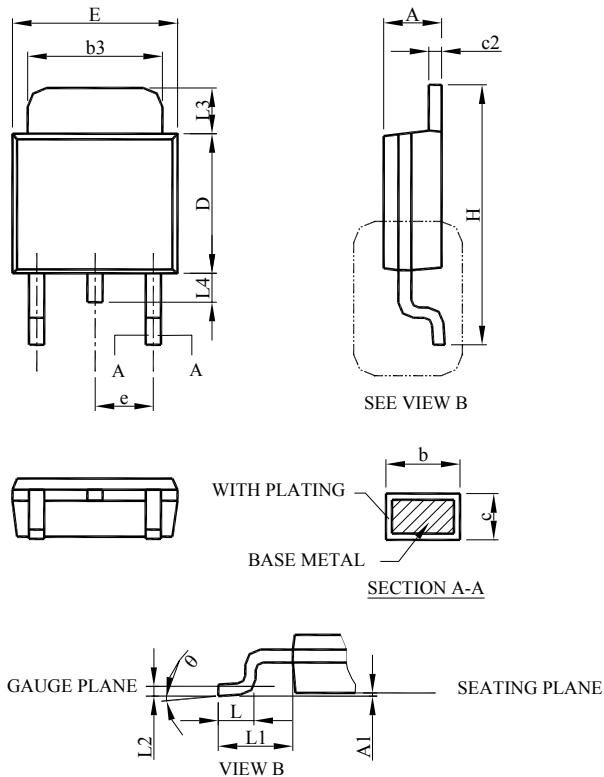


Fig 12. Gate Charge Waveform

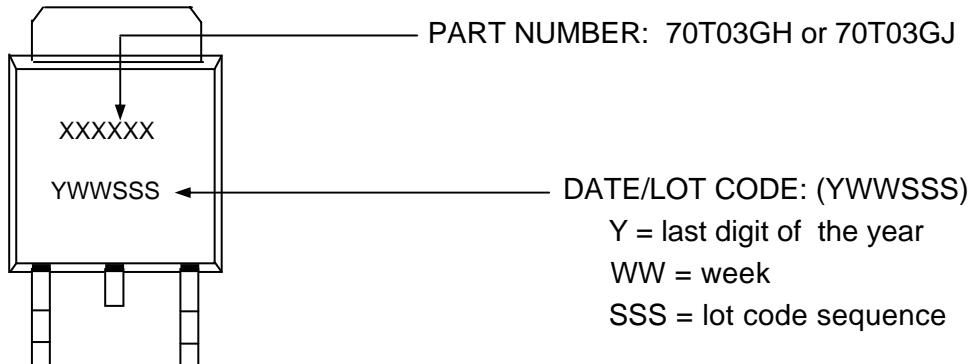
PHYSICAL DIMENSIONS



SYMBOL	TO-252-3L	
	MILLIMETERS	
	MIN.	MAX.
A	1.80	2.80
A1	0.00	0.13
b	0.40	1.00
b3	4.80	5.90
c	0.35	0.65
c2	0.40	0.89
D	5.10	6.30
E	6.00	7.00
e	2.30 BSC	
H	7.80	11.05
L	1.00	2.55
L1	2.20	3.05
L2	0.35	0.65
L3	0.50	2.03
L4	0.50	1.20
θ	0°	8°

*Dimensions do not include mold protrusions.

PART MARKING



PACKING:

Moisture sensitivity level MSL3

TO-252: 3000 pcs in antistatic tape on a reel packed inside a moisture barrier bag (MBB).

TO-251: 1000pcs in an antistatic bag packed inside a moisture barrier bag (MBB).

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